



11A 650V N-CHANNEL POWER MOSFET

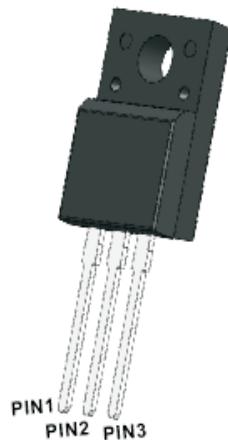
TO-220F-3L(*Prefix :F)

Description

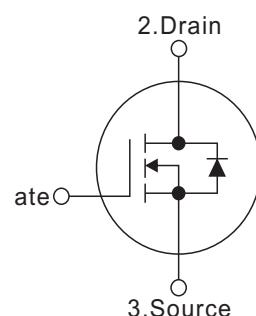
The power MOSFET using super junction technology that can realize very low on-resistance and gate charge. It will provide much high efficiency by using optimized charge coupling technology. These user friendly devices give an advantage of Low EMI to designers as well as low switching loss.

Features

- $R_{DS(ON)} \leq 360\text{m}\Omega$ @ $V_{GS}=10\text{V}$, $I_D=5\text{A}$
- Fast switching capability
- Low On-Resistance
- 100% Avalanche tested
- 100% ΔV_{DS} tested



ROHS
COMPLIANT



Mechanical data

- Case: TO-220F-3L
- Approx Weight: 1.767g (0.062oz)
- RoHS compliant
- Case Material: "Green" molding compound,
UL flammability classification 94V-0, "Halogen-free".

Absolute Maximum Ratings ($T_a=25^\circ\text{C}$, Unless Otherwise Specified)

Parameter	Symbols	Ratings	Units
Drain-Source Voltage	V_{DS}	650	V
Gate-Source Voltage	V_{GS}	± 30	V
Continuous Drain Current $T_c=25^\circ\text{C}$	I_D	11	A
Pulsed Drain Current (Note 2)	I_{DM}	44	A
Avalanche Energy Single Pulsed (Note 3)	E_{AS}	220	mJ
Power Dissipation ($T_c = 25^\circ\text{C}$)	P_D	32.8	W
Operating junction and storage temperature	T_J, T_{STG}	-55 ~+150	$^\circ\text{C}$

Notes:

- Absolute maximum ratings are those values beyond which the device could be permanently damaged.
Absolute maximum ratings are stress ratings only and functional device operation is not implied.
- Repetitive Rating: Pulse width limited by maximum junction temperature.
- $L=10\text{mH}$, $V_{DD}=50\text{V}$, $R_G=25\Omega$, Starting $T_J=25^\circ\text{C}$

Thermal Resistance

Parameter	Symbols	Ratings	Units
Thermal resistance, junction – case.	R_{thJC}	3.8	$^\circ\text{C/W}$
Thermal resistance, junction – ambient(min. footprint)	R_{thJA}	62	$^\circ\text{C/W}$



Electrical Characteristics (Ta=25°C, Unless Otherwise Specified)

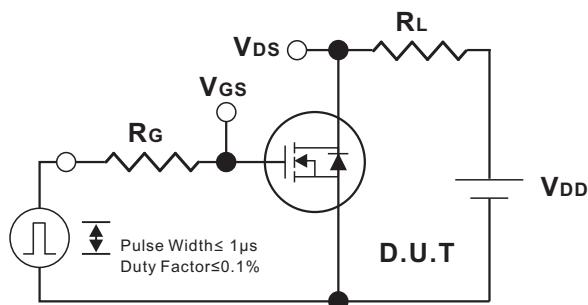
Parameter	Symbols	Test Conditions	Min	Typ	Max	Units
Off Characteristics						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V,I _D =250uA	650			V
Drain-Source Leakage Current	I _{DSS}	V _{DS} =650V,V _{GS} =0V			1	uA
Gate- Source Leakage Current	Forward	I _{GSS}	V _{GS} =30V,V _{DS} =0V		100	nA
	Reverse		V _{GS} =-30V,V _{DS} =0V		-100	
On Characteristics						
Gate Threshold Voltage	V _{GS(TH)}	V _{DS} =V _{GS} ,I _D =250uA	3		5	V
Static Drain-Source On-State Resistance	R _{D(S)} (ON)	V _{GS} =10V,I _D =5A		275	360	mΩ
Transconductance	g _{fs}	V _{DS} =10V,I _D =5A		8.2		S
Dynamic Characteristics						
Input Capacitance	C _{ISS}	V _{DS} =50V, V _{GS} =0V, f=1.0MHz		557		pF
Output Capacitance	C _{OSS}			70		pF
Reverse Transfer Capacitance	C _{rss}			16		pF
Gate resistance	R _G	V _{DS} =0V,FREQ=1.00MHz		19		Ω
Switching Characteristics						
Total Gate Charge (Note 1)	Q _G	V _{DS} =520V,V _{GS} =10V, I _D =11A (NOTE1,2)		22		nC
Gate-Source Charge	Q _{GS}			4		nC
Gate-Drain Charge	Q _{GD}			8		nC
Turn-On Delay Time (Note 1)	t _{D(ON)}	V _{DS} =400V,I _D =11A R _G =25Ω (NOTE1,2)		69.7		ns
Turn-On Rise Time	t _R			69.5		ns
Turn-Off Delay Time	t _{D(OFF)}			145		ns
Turn-Off Fall Time	t _F			59		ns
Drain-Source Diode Characteristics And Maximum Ratings						
Maximum Body-Diode Continuous Current	I _S				11	A
Drain-Source Diode Forward Voltage (Note 1)	V _{SD}	I _{SD} =11A,V _{GS} =0V			1.2	V
Reverse Recovery Time (Note 1)	t _{rr}	I _F =11A di/dt=100A/us		377		ns
Reverse Recovery Charge	Q _{rr}			3.4		uC

Notes:

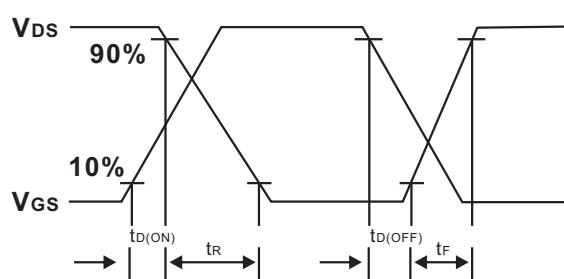
1. Pulse Test: Pulse width ≤ 300μs, Duty cycle ≤ 2%.
2. Essentially independent of operating temperature.



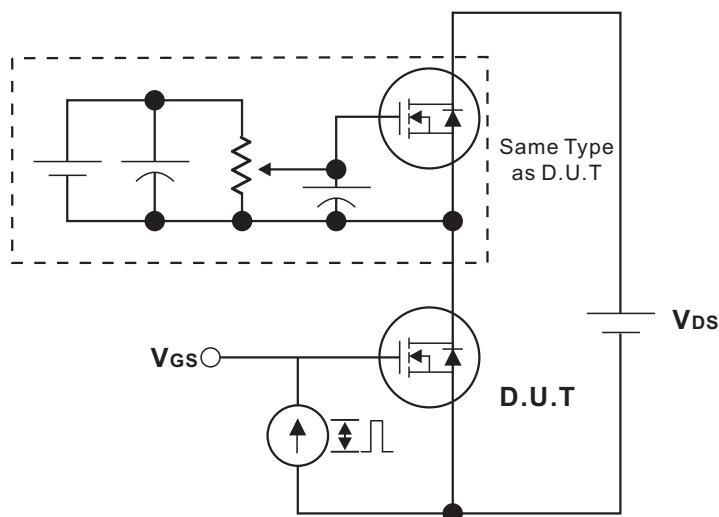
Test Circuits and waveforms



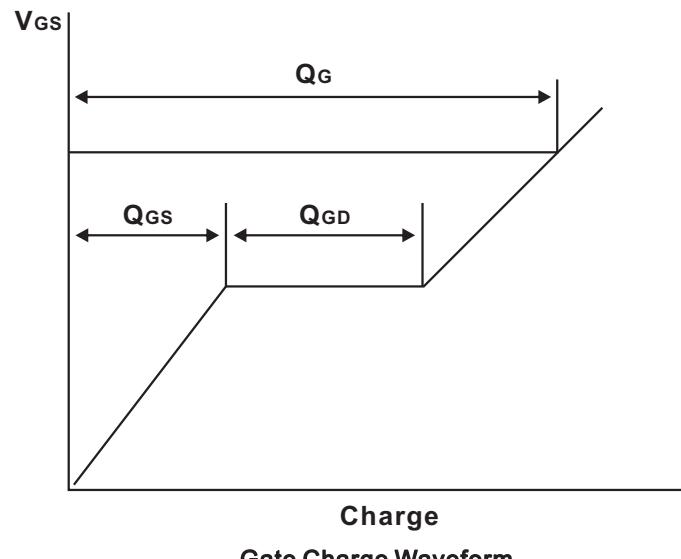
Switching Test Circuit



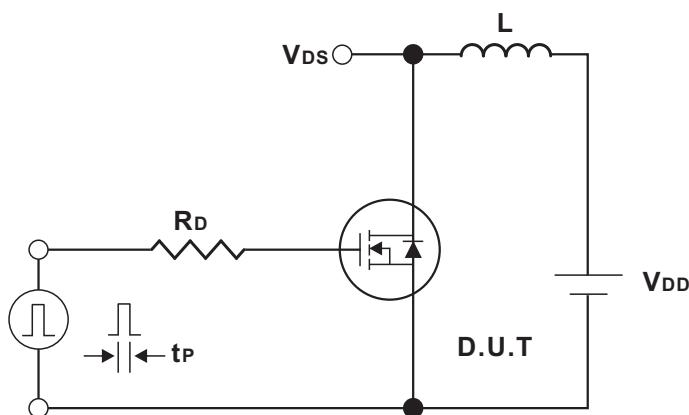
Switching Waveforms



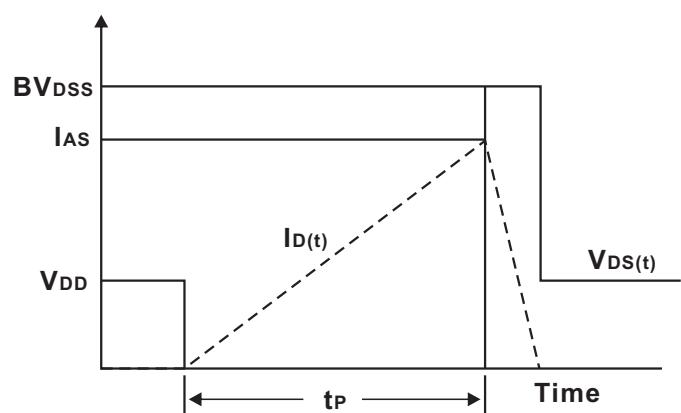
Gate Charge Test Circuit



Gate Charge Waveform



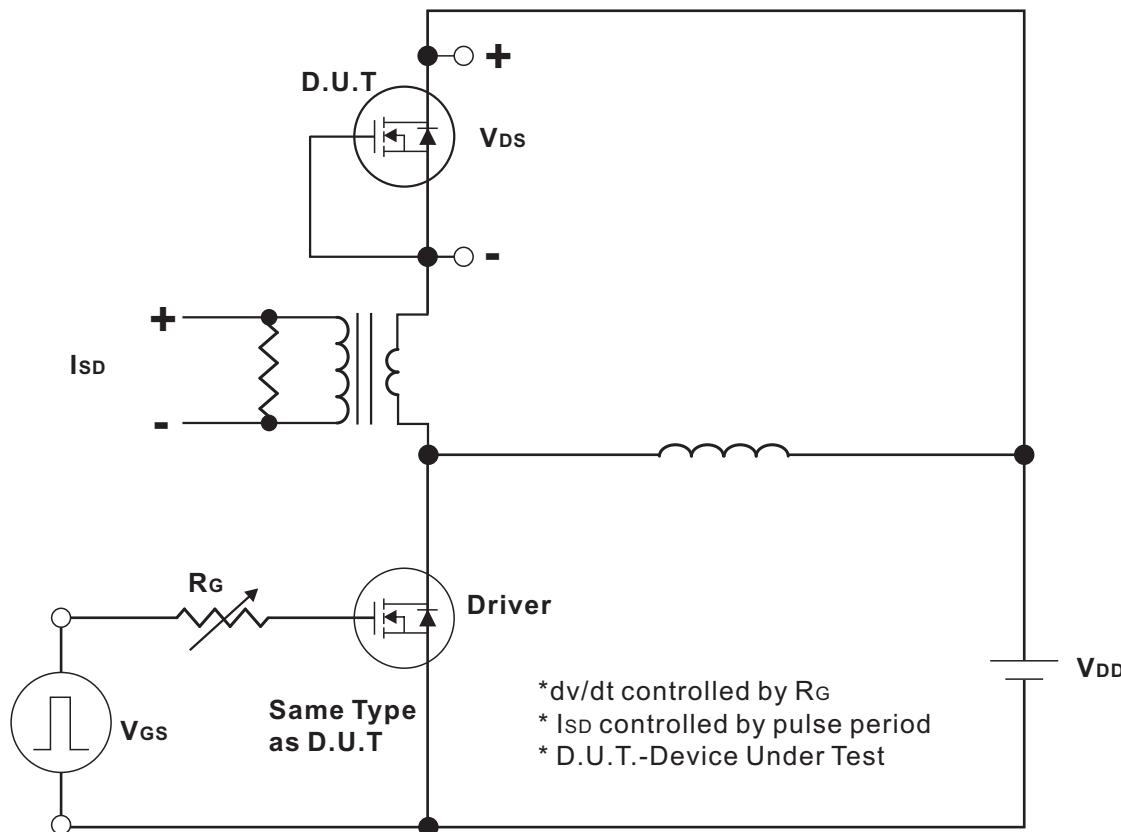
Unclamped Inductive Switching Test Circuit



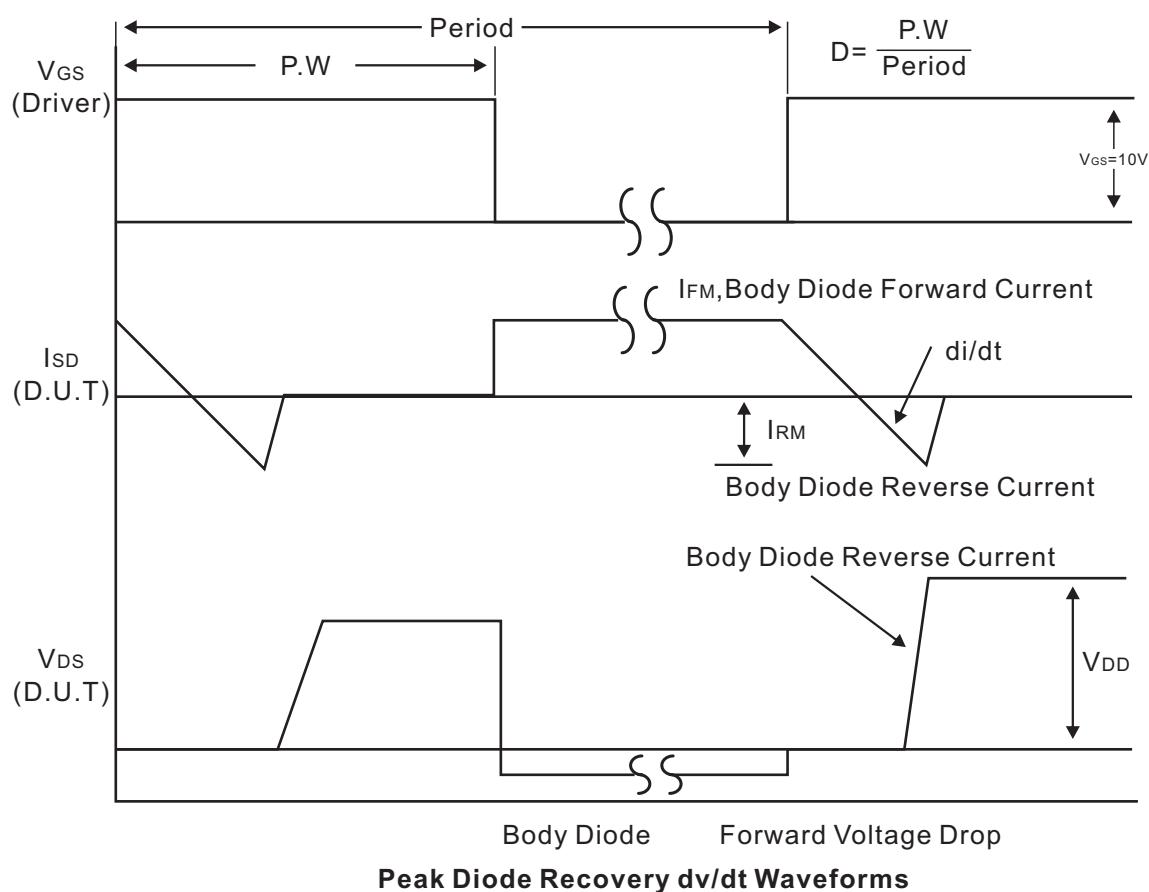
Unclamped Inductive Switching Waveforms



Test Circuits and waveforms



Peak Diode Recovery dv/dt Test Circuit





Typical Characteristics

Fig.1 Output characteristics

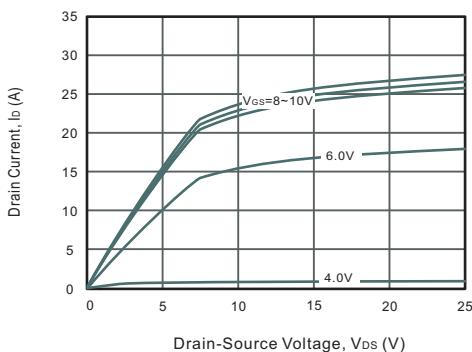


Fig.2 Power Dissipation

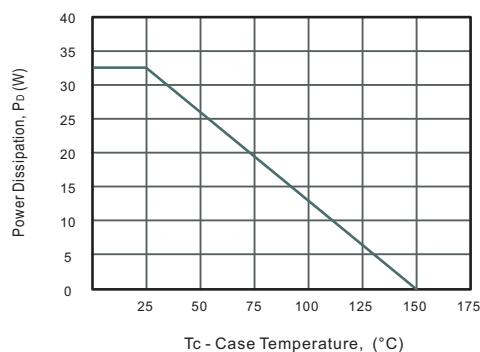


Fig.3 Drain Current Derating

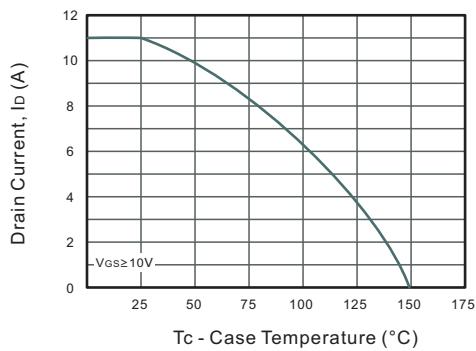


Fig.4 Drain-Source On-Resistance vs. Drain Current

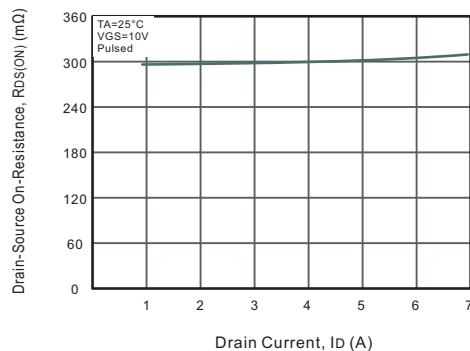


Fig.5 Gate Threshold Voltage vs. Junction Temperature

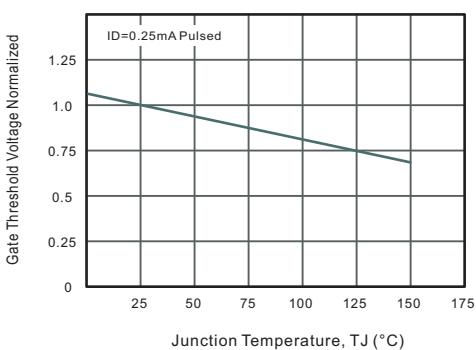


Fig.6 Body-diode Forward Characteristics

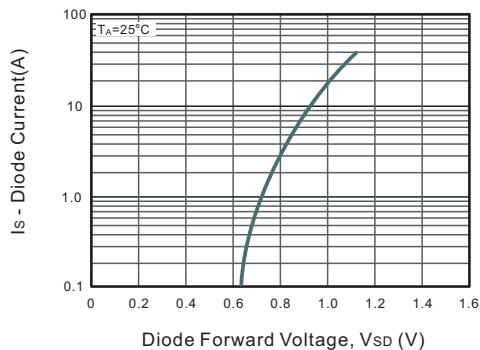


Fig.7 Drain-Source On-Resistance vs. Junction Temperature

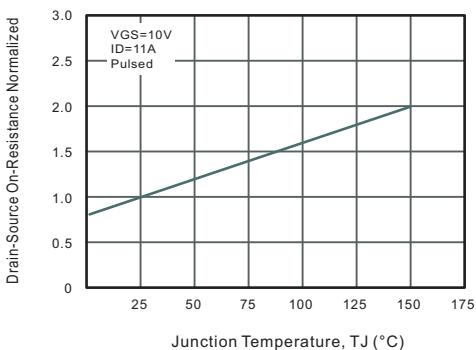
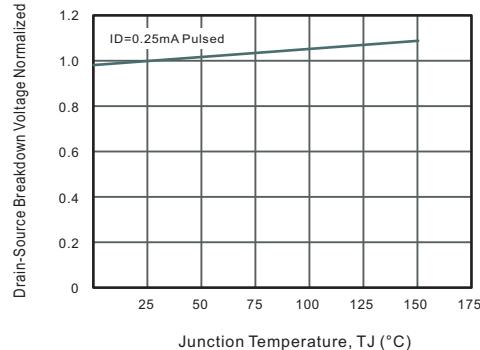


Fig.8 Breakdown Voltage vs. Junction Temperature





Typical Characteristics

Fig.9 Capacitance Characteristics

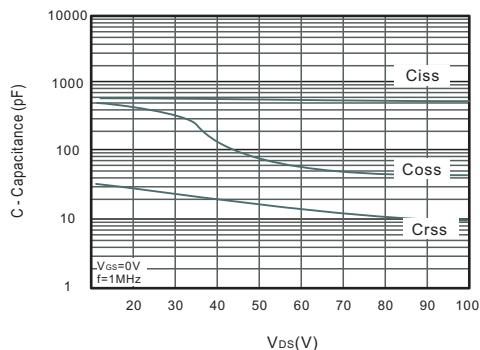


Fig.10 Gate Charge Characteristics

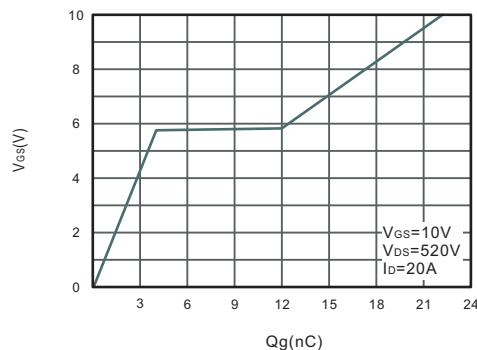


Fig.11 Safe Operating Area

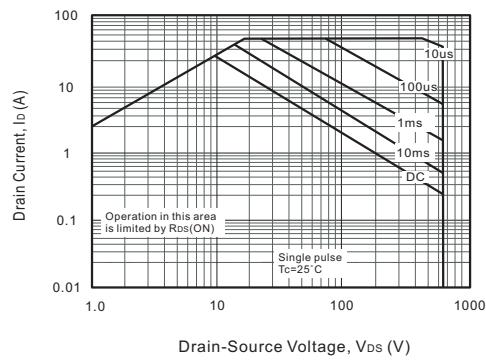
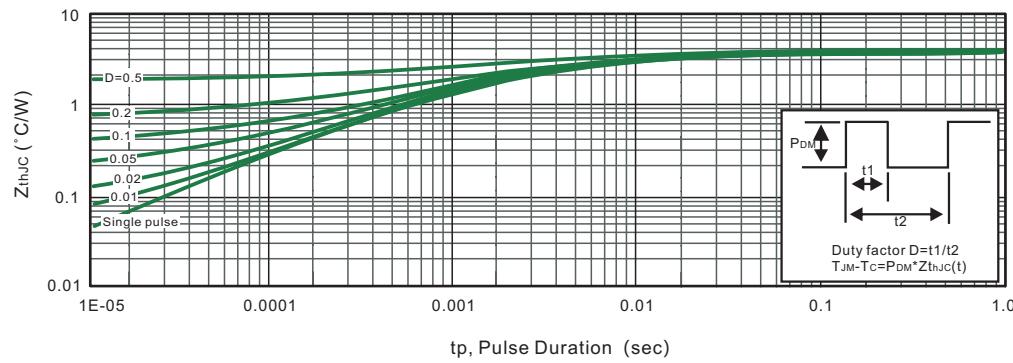


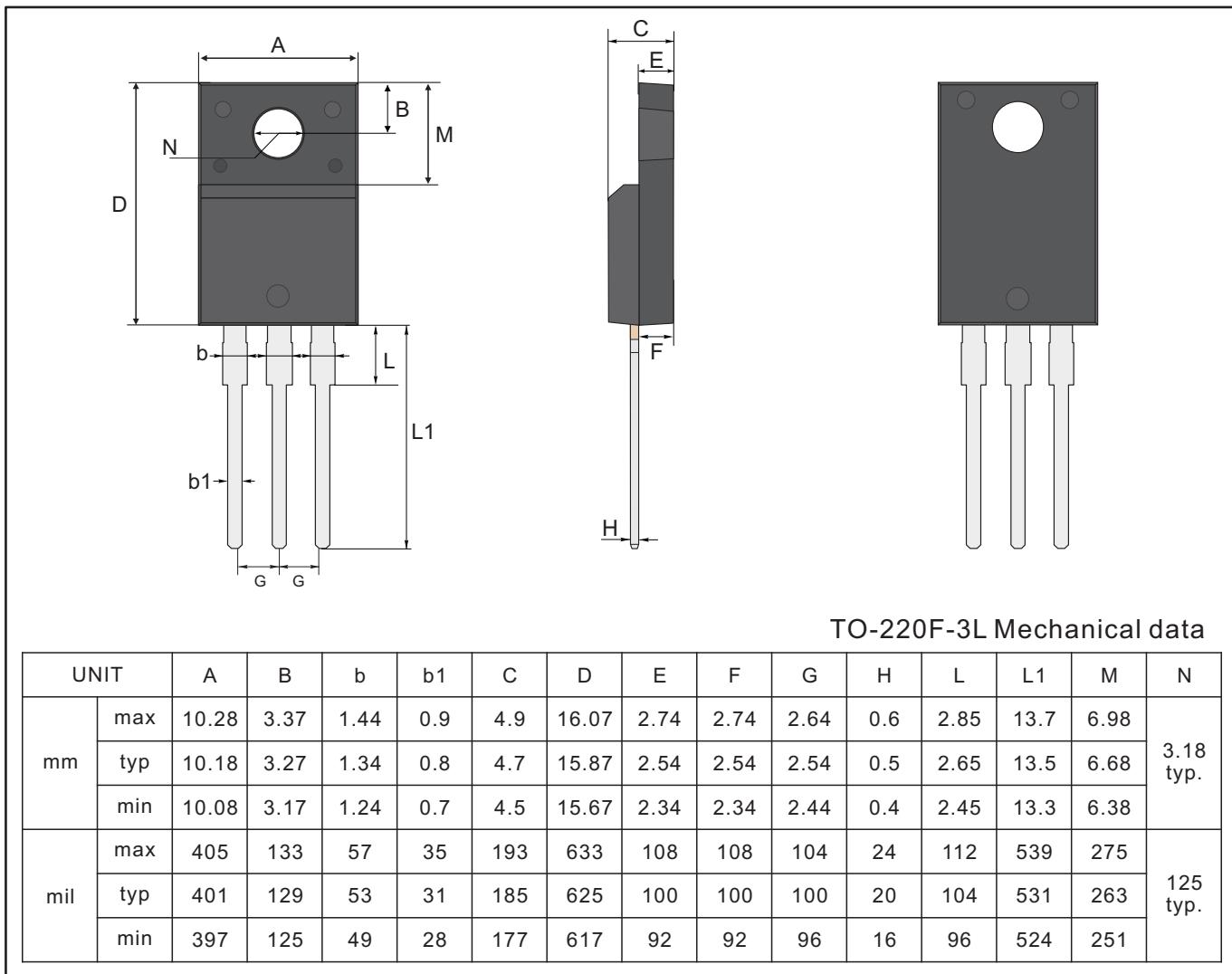
Fig.12 Max. Transient Thermal Impedance





Package Outline
Through Hole Package ; 3 leads

TO-220F-3L



Marking

Type number	Marking code
F65R360TP1	F65R360TP1



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